Search Notes				

Application/Control No.	Applicant(s)/Patent under Reexamination	
10/667,305	SATOH, NOBUYUKI	
Examiner	Art Unit	
Hai C. Pham	2861	

SEARCHED				
Class	Subclass	Date	Examiner	
347	116-117, 233, 240. 251-254	6/25/2005	НР	
356	603-605	6/25/2005	HP	
399	72, 301	6/25/2005	HP	
	394-396			
355	41	6/25/2005	HP	

INTERFERENCE SEARCHED				
Class	Subclass	Date	Examiner	
		=		

SEARCH NO (INCLUDING SEARCI	DTES H STRATEGY)
	DATE	EXMR
EAST	6/24/2005	HP
	6/25/2005	НР